



Supporting Online Material for

Oxide Interfaces—An Opportunity for Electronics

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Fig. S1

Table S1

References

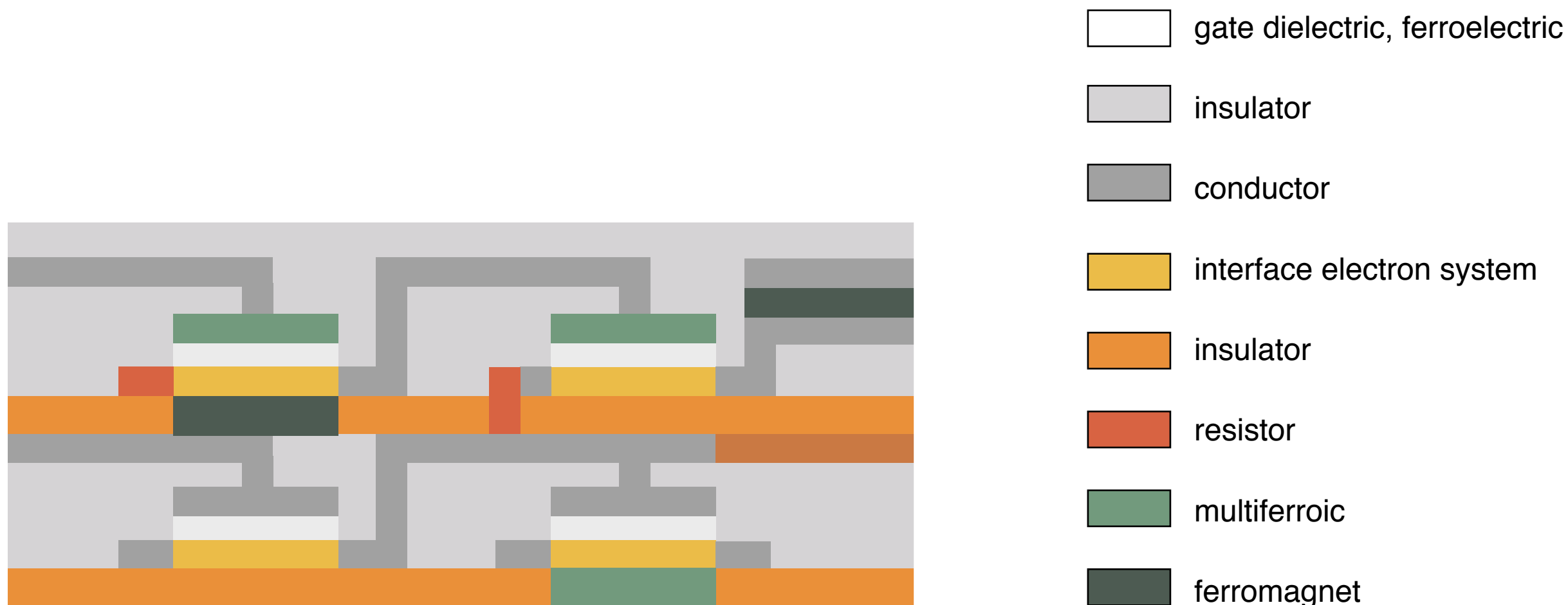


Figure S1:

Sketch illustrating possible multilayer devices using interfaces in complex oxides. The illustration shows a cross-sectional cut through a hypothetical device.

Table S1:

	GaAs - Al _x Ga _{1-x} As	LaAlO ₃ - SrTiO ₃
Carrier density n (without gate field)	several 10^{10} - several $10^{11}/\text{cm}^2$	several $10^{13} / \text{cm}^2$
Sheet resistance ρ ($H=0$)	order of $10\text{-}100 \Omega/\square$ (low T , samples with high- μ)	$\sim 200 \Omega/\square$ (4.2 K) $\sim 20 \text{ k}\Omega/\square$ (300 K)
Thickness d	order of 10 nm	~ 10 nm (4.2 K) ≤ 4 nm, possibly 0.4 nm (300 K)
Equivalent volume carrier concentration	order of $10^{17} / \text{cm}^3$	order of $10^{20} / \text{cm}^3$
Typical thicknesses of the host layers in heterojunctions (<i>e.g.</i> , cap layers)	tens of nanometer	≥ 1.6 nm LaAlO ₃ (4 unit cells)
Hall mobility μ	$\geq 10^7 \text{ cm}^2/\text{Vs}$ (4.2 K)	$\leq 1000 \text{ cm}^2/\text{Vs}$ (4.2 K) $\leq 10 \text{ cm}^2/\text{Vs}$ (300 K)
Effective mass m of carriers at interface	$m_e \sim 0.07 m_0$	$m_e \sim 3 m_0$
Mean scattering time τ , mean free path	100 psec, order of 100 μm	psec, tens of nm (4.2 K)
v_F	$\sim 3 \times 10^7 \text{ cm/s}$	several 10^6 cm/s
Magnetic flux density inducing quantum Hall filling factor $\nu=1$	order of 10 T	order of 1000 T
Energy dependence of density of states $N(E)$	step function of 2-DEG (ideal case)	complex function reflecting the $N(E)$ -dependence of the Ti-, La-, and O-ions

	GaAs - Al _x Ga _{1-x} As	LaAlO ₃ - SrTiO ₃
Remarks	<ul style="list-style-type: none"> • two-dimensional electron gas (2-DEG); • quantum well induced by band bending; • 2D-subbands of nominally free electrons 	<ul style="list-style-type: none"> • two-dimensional electronic liquid (2-DEL); • metal-insulator transition at a few 10¹² /cm²; quantum well structure as shown in Fig. 4; • 2D-subbands composed of ionic orbital states with local character (<i>e.g.</i>, Ti 3<i>d</i>, La 5<i>d</i>, O 2<i>p</i>); • 2D-superconducting ground state; • strong spin-orbit coupling.

Table S1:

Characteristic values of selected, fundamental parameters of LaAlO₃-SrTiO₃ (TiO₂-terminated) interfaces compared to the ones of GaAs-Al_xGa_{1-x}As interfaces. The table presents typical numbers of samples with good properties as published by January 2010. For data on the GaAs-Al_xGa_{1-x}As interfaces see, *e.g.*, (S1-S7). With respect to the data of the LaAlO₃-SrTiO₃ interfaces see, *e.g.*, for mobility and carrier concentration (S8-S15), superconducting transition (S12, S16), thickness of the electron system (S15-S20), spin-orbit coupling (S21), effective mass (S22, S23), spectral density of states (S23), with overviews given in (S24-S26). The estimation of v_F is based on the model of free electrons using $n_{2D}=k_F^2/2\pi$, the estimations of the scattering time and mean free path are based on the Drude model.

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